Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,349	TAKANO, TADASHI
Examiner	Art Unit
Dang D. Le	2834

	SEAR	CHED	
Class	Subclass	Date	Examiner
310	43 45 71 68B 254 258 259	12/1/2005	DL
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
all	all	12/1/2005	DL
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SEARC (INCLUDING SEA	H NOTES ARCH STRATEGY	<b>'</b> )
	DATE	EXMR
search history included	12/1/2005	DL